

Notice of References Cited	Application/Control No. 10/056,394	Applicant(s)/Patent Under Reexamination CHUAN ET AL.	
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U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-2003/0020986 A1	01-2003	Pang et al.	359/152
B	US-			
C	US-			
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